

**Search Notes**

Application/Control No.

10/682,542

Examiner

X L. Bautista

Applicant(s)/Patent under  
Reexamination

WEE ET AL.

Art Unit

2179

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST Search	11/14/2005	XB